



Design and implementation of a photovoltaic I-V curve tracer: Solar modules characterization under real operating conditions

H. Amiry^a, M. Benhmida^{a,*}, R. Bendaoud^a, C. Hajjaj^a, S. Bounouar^a, S. Yadir^{a,b}, K. Raïs^a, M. Sidki^a

^a Laboratory of Electronics, Instrumentation and Energy (LEIE), Faculty of Science, Chouaib Doukkali University, Department of Physics, Route Ben Maachou, B.P 20, 24000 El Jadida, Morocco

^b Laboratory of Materials, Processes, Environment and Quality, ENSA, Cadi Ayyad University, Safi, Morocco

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ABSTRACT

The performance of a photovoltaic (PV) module depends on real operating conditions such as solar irradiance, ambient temperature, and wind speed, in addition to solar module technologies. To characterize a PV module under these conditions, the measure of the entire current-voltage (I-V) curve in short time requires a suitable data acquisition device. This paper outlines the features of a low-cost acquisition device to characterize a PV module under real operating conditions. It is based on a set of MOSFET IRF540N, and load resistances, an Arduino board, and sensors of current and voltage with high resolution and sampling rate. This system permits to sweep the entire I-V curve by taking a current-voltage point (I, V) within one msec. The effects of operating temperature and solar irradiance on the module performance are investigated. The physical parameters of the module have been extracted by two methods using three solar cell models. The temperature correction coefficients for current, voltage, and efficiency are calculated. The results show a good agreement with those found in the literature.

1. Introduction

The massive global energy consumption and the expected depletion of fossil fuel resources are mainly behind the growing interest in exploring alternative energy sources such as solar energy. Research in the field of photovoltaic energy has grown rapidly over the last three decades relative to various aspects such as modeling, control, and physical extraction parameters [1–5]. The electric output performance of PV modules depend highly on weather conditions [6–10]. These performances are usually evaluated by manufacturers under standard test conditions (STC: operating temperature of 25 °C, irradiance of 1000 W/m² and AM = 1.5), which are almost never encountered [11,12]. The I-V curve extracted under real operating conditions requires taking the fast variation of climatic conditions into account [11–14]. Thus, in order to reduce the effect of solar irradiance and temperature fluctuations, several techniques are used to automatically measure the I-V characteristic of PV modules. Cotfas et al. [15] used the capacitor charging cycle as an automatic variable load to measure the PV cell I-V curve by about a hundredth of a second. However, fluctuations affecting the obtained I-V curve were observed. Thomas Mambrini [14] developed a technique based on the bipolar transistor to vary the load resistance and acquire 30 points of the PV module I-V

characteristic in a relatively long time, 6–8 s. Kuai et al. [16] designed a device based on an electronic load with the linear MOSFET APL501J to cover the complete range of PV panel I-V characteristic but the sampling time and measurement resolution were not indicated. Belmili et al. [17] designed and developed an electronic circuit based on several MOSFET IRFP150N connected in parallel to vary the load resistance and allow the acquisition of PV I-V characteristic, but the sampling time and measurement resolution were not indicated and remarkable fluctuations were observed on the I-V curve. Papageorgas et al. [18] implemented a new method to vary the load resistance by using a MOSFET to measure an I-V curve of 36 points in a time average of 70 ms with visible fluctuations. Tihane et al. [11] used Arduino board and relays to switch between several resistances in order to vary the load resistance and extract the entire PV I-V curve. This solution was based on the use of relays characterized by a long response time. The I-V curve also showed visible fluctuations. In addition, there were several commercial systems to characterize the PV modules, but they were relatively expensive and had a relatively long measuring time [19].

To overcome these problems, an electronic circuit is realized to extract the complete PV I-V curve under different operating conditions. This device is composed of several MOSFET IRF540N controlled by an

* Corresponding author.

E-mail address: benhmida@gmail.com (M. Benhmida).

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